Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10575347	KIM ET AL.
Examiner	Art Unit
Jennifer F Chang	4158

SEARCHED							
Class	Subclass	Date	Examiner				
343	702	11/14/2007	Jennifer F.				
			Chang				

SEARCH NOTES				
Search Notes	Date	Examiner		
EAST Search History	11/14/2007	Jennifer F. Chang		
Inventor Search in eDAN	11/14/2007	Jennifer F. Chang		

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			

U.S. Patent and Trademark Office Part of Paper No.: 20071114